

Search Notes

Application/Control No.

10/066,049

Examiner

Djenane M. Bayard

Applicant(s)/Patent under
Reexamination

PICKEL ET AL.

Art Unit

2141

SEARCHED

Class	Subclass	Date	Examiner
709	248	7/6/2006	DB
709	228	7/6/2006	DB
709	229	7/6/2006	DB
707	200-203	7/6/2006	DB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
709	248	7/6/2006	DB
709	228/229	7/6/2006	DB
707	200/203	7/6/2006	db

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	7/6/2006	DB
Consulted with William Vaughn	7/6/2006	fb